- Low Temperature Coefficient
- Wide Operating Current . . . 400 μA to 10 mA
- 0.27-Ω Dynamic Impedance
- ±1% Tolerance Available
- Specified Temperature Stability
- Easily Trimmed for Minimum Temperature Drift
- Fast Turn-On
- Three-Lead Transistor Package

# description

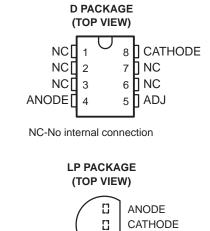
The LM236-2.5 and LM336-2.5 integrated circuits are precision 2.5-V shunt regulator diodes. These monolithic references operate as low temperature coefficient 2.5-V zeners with a 0.2- $\Omega$  dynamic impedance. A third terminal provided on the circuit allows the reference voltage and temperature coefficient to be easily trimmed.

The series are useful as precision 2.5-V low-voltage references  $(V_7)$  for digital voltmeters,

power supplies, or operational amplifier circuitry. The 2.5-V voltage reference makes it convenient to obtain a stable reference from 5-V logic supplies. Since the series operate as shunt regulators, they can be used as either positive or negative voltage references.

symbol

The LM236-2.5 is characterized for operation from  $-25^{\circ}$ C to  $85^{\circ}$ C. The LM336-2.5 is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C.





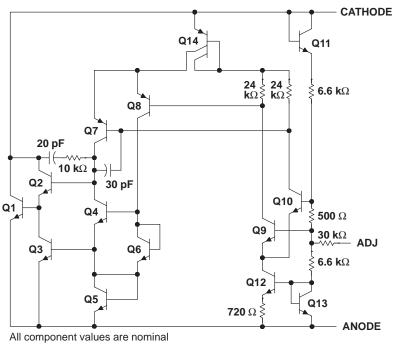
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#### **AVAILABLE OPTIONS**

	PACKAGEI	CHIP FORM			
TA	SMALL OUTLINE (D)	PLASTIC (LP)	(Y)		
0°C to 70°C	LM336D-2.5	LM336LP-2.5	LM336Y-2.5		
−25°C to 85°C	LM236D-2.5	LM236LP-2.5	_		

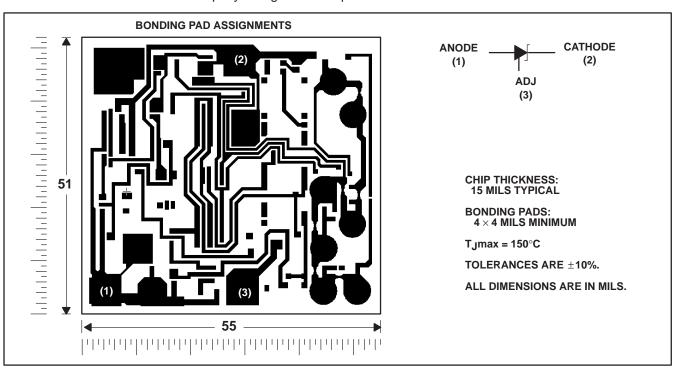
The D package is available taped and reeled. Add the suffix R to the device type (i.e., LM336DR-2.5).

## schematic diagram



## LM336Y-2.5 chip information

This chip, when properly assembled, displays characteristics similar to the LM336-2.5 (see electrical tables). Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.





SLVS063A - NOVEMBER 1988 - REVISED AUGUST 1995

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

# electrical characteristics at specified free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T <sub>A</sub> ‡	LM236-2.5			LM336-2.5			UNIT	
		TEST CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	ONIT	
VZ	Reference voltage	I <sub>Z</sub> = 1 mA	LM236, LM336	25°C	2.44	2.49	2.54	2.39	2.49	2.59	V
			LM236A, LM336B		2.465	2.49	2.515	2.44	2.49	2.54	
ΔVZ(ΔΤ)	Change in reference voltage with temperature§	V <sub>Z</sub> adjusted to 2.490 V, I <sub>Z</sub> = 1 mA		Full range		3.5	9		1.8	6	mV
$\begin{array}{c} \Delta V_{Z(\Delta I)} & \text{Change in reference} \\ \text{voltage with current} \end{array}$	Change in reference	I <sub>7</sub> = 400 μA to 10 mA		25°C		2.6	6		2.6	10	mV
	12 = 400 μΑ (Ο 10 ΠΙΑ	Full range		3	10		3	12	1111		
$\Delta V_{Z(\Delta t)}$	Long-term change in reference voltage	I <sub>Z</sub> = 1 mA		25°C		20			20		ppm/khr
$z_Z$	Reference impedance	I <sub>Z</sub> = 1 mA, f = 1 kHz	25°C		0.2	0.6		0.2	1	Ω	
			Full range		0.4	1		0.4	1.4		

Full range is -25°C to 85°C for the LM236-2.5 and 0°C to 70°C for the LM336-2.5.

# electrical characteristics, T<sub>A</sub> = 25°C

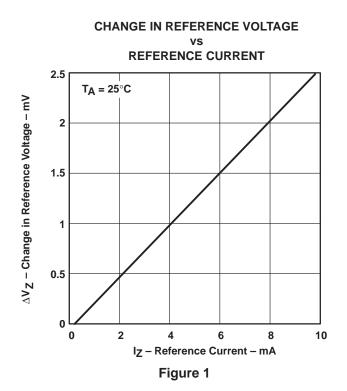
	PARAMETER	TEST CONDITIONS	LM336Y-2.5			UNIT
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{Z}$	Reference voltage	$I_Z = 1 \text{ mA}$	2.39	2.49	2.59	V
$\Delta V_{Z(\Delta I)}$	Change in reference voltage with current	$I_Z = 400 \mu A \text{ to } 10 \text{ mA}$		2.6	10	mV
$\Delta V_{Z(\Delta t)}$	Long-term change in reference voltage	$I_Z = 1 \text{ mA}$		20		ppm/khr
$Z_{\overline{Z}}$	Reference impedance	$I_Z = 1 \text{ mA},  f = 1 \text{ kHz}$		0.2	1	Ω

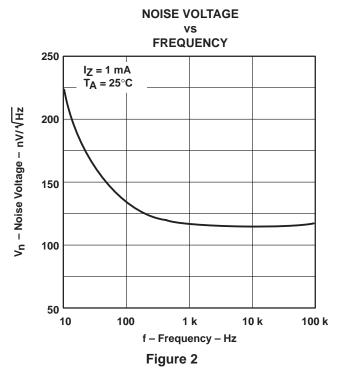


<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

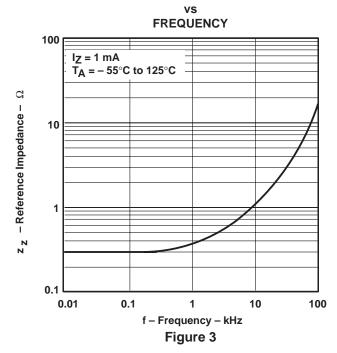
<sup>§</sup> Temperature stability (change in reference voltage with temperature) for these devices is ensured by design. Design limits are specified over the indicated temperature and supply voltage ranges. These limits are not used to calculate outgoing quality levels.

## TYPICAL CHARACTERISTICS





### REFERENCE IMPEDANCE





## **APPLICATION INFORMATION**

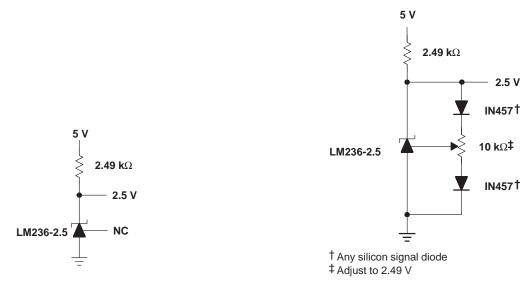


Figure 4. 2.5-V Reference

Figure 5. 2.5-V Reference With Minimum Temperature Coefficient

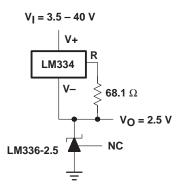


Figure 6. Wide Input Range Reference

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